

INTERNATIONAL STANDARD

NORME INTERNATIONALE



AMENDMENT 1

AMENDEMENT 1

Metallic communication cable test methods – PREVIEW

Part 4-7: Electromagnetic compatibility (EMC) – Test method for measuring of transfer impedance Z_T and screening attenuation a_s or coupling attenuation a_c of connectors and assemblies up to and above 3 GHz – Triaxial tube in tube method

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Méthodes d'essai des câbles métalliques de communication –

Partie 4-7: Compatibilité électromagnétique (CEM) – Méthode d'essai pour mesurer l'impédance de transfert Z_T et l'affaiblissement d'écrantage a_s ou l'affaiblissement de couplage a_c des connecteurs et des cordons jusqu'à 3 GHz et au-dessus – Méthode triaxiale en tubes concentriques





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FOREWORD

This amendment has been prepared by IEC technical committee 46: Cables, wires, waveguides, RF connectors, RF and microwave passive components and accessories.

The text of this amendment is based on the following documents:

FDIS	Report on voting
46/679/FDIS	46/682/RVD

Full information on the voting for the approval of this amendment can be found in the report on voting indicated in the above table.

The committee has decided that the contents of this amendment and the base publication will remain unchanged until the stability date indicated on the IEC website under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

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IMPORTANT – The 'colour inside' logo on the cover page of this publication indicates that it contains colours which are considered to be useful for the correct understanding of its contents. Users should therefore print this document using a colour printer.

Add, after Annex D, the following new Annex E:

Annex E (informative)

Direct measurement of screening effectiveness of connectors

E.1 General

IEC 62153-4-7 describes the measurement of transfer impedance and screening or coupling attenuation of connectors and cable assemblies with the tube in tube procedure. According to IEC 62153-4-7, connectors usually are measured with a short piece of connecting cable, see for example Figure 2.

In different cases it may be required to measure the screening effectiveness direct on the connector or without connecting cable, e.g. to evaluate the EMC of the interface of the mated connectors. The following describes the test set-up for direct connector measurement.

E.2 Test set-up

The test set-up and measurements are in principle the same than in Clauses 8 to 10 of this document.

Contrary to the set-ups in Clauses 8 to 10 of this document, the RF-tight tube in tube and the screening cap are direct connected to the connector under test (CUT), see Figure E.1; e.g. by a screwing joint of the connector under test to the extension tube and the screening cap. The torque of this screwing joint shall be specified by the connector manufacturer.

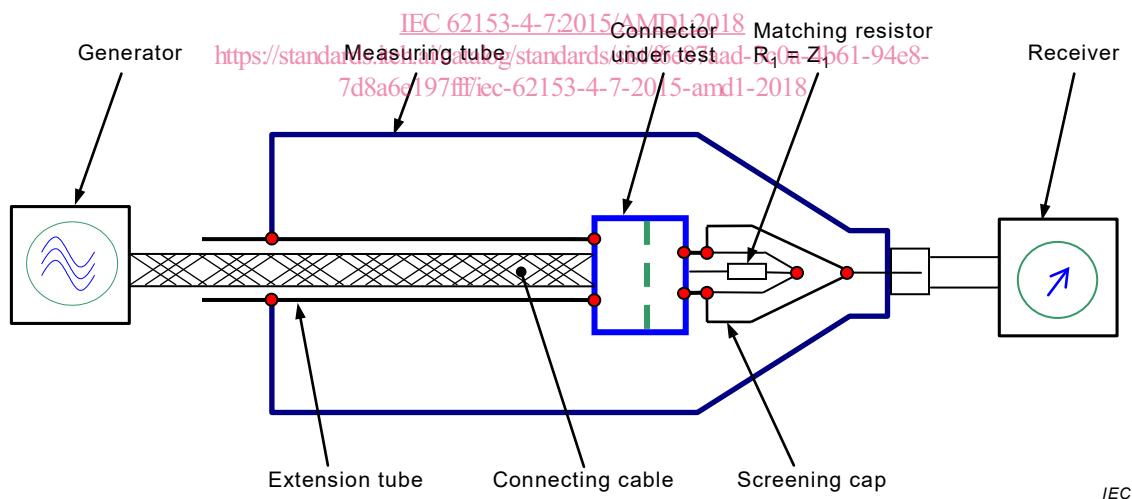


Figure E.1 – Principle of the test set-up to measure transfer impedance and screening attenuation of a connector

The same applies in principle to the set-up for measuring cable assemblies, see Figure E.2.

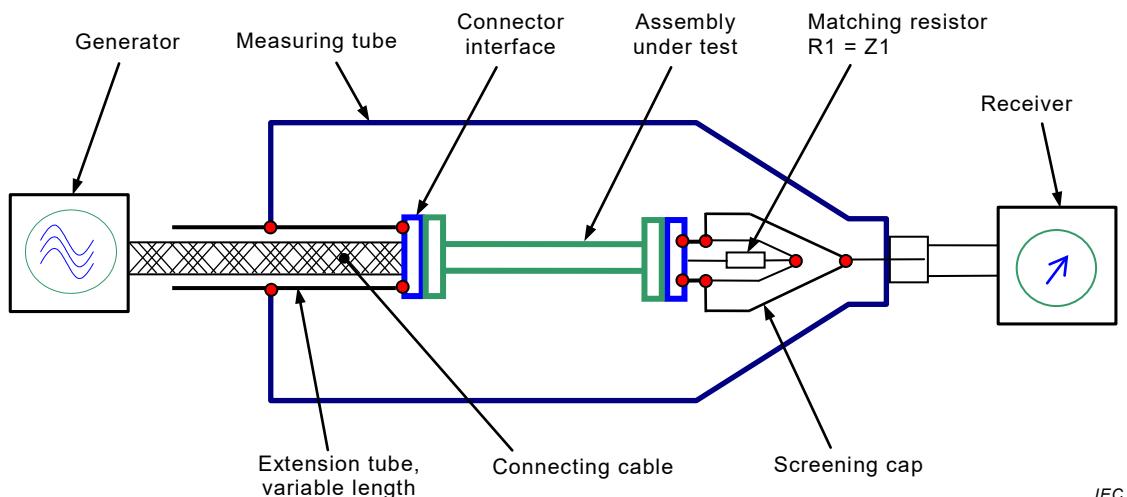
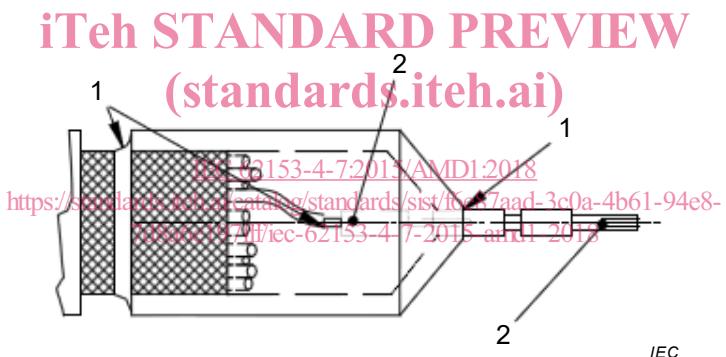


Figure E.2 – Principle of the test set-up to measure transfer impedance and screening attenuation of a cable assembly

If a multi conductor cable is tested instead of a single-conductor cable, a combination of inner conductors (cores) shall be selected such that their impedance to the screen is closest to the internal impedance of the test receiver, see Figure E.3 (e.g. determined by means of a reflectometer).



Key

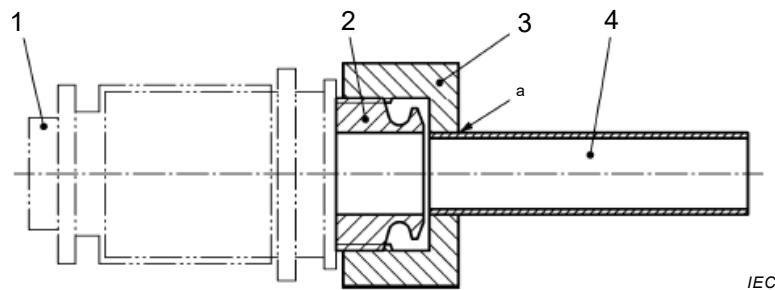
- 1 connection
- 2 terminating impedance 50Ω
- 3 inner contact from RF connector connected to the shielded tube

Figure E.3 – Example of sample preparing

E.3 Construction details of test set-up

The connection of the RF-tight tube as well as the RF-tight connection of the screening cap may influence the test results considerably. Worse mounted connections may lead to leakages and to poor test results.

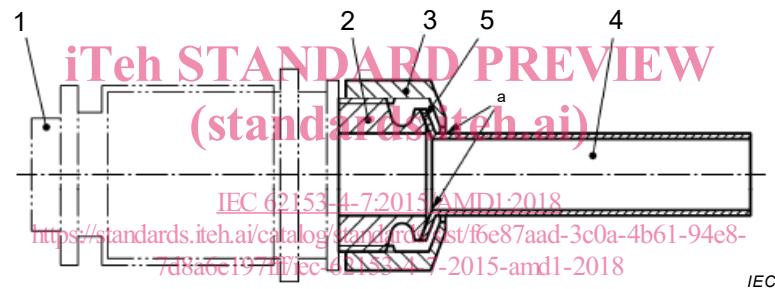
Figures E.4 and E.5 give examples of how to connect the tube in tube and the screening cap to the CUT.



Key

- 1 mating connector
- 2 coupling
- 3 bush (Cu-material)
- 4 copper tube
- ^a RF-density connection (soldered for example)

Figure E.4 – Screening tube with separate nut



Key

- 1 mating connector
- 2 coupling
- 3 nut
- 4 copper tube
- 5 cone
- ^a Matching edge-raised or chamfered

Figure E.5 – Screening fixed with associated nut

Bibliography

Add, at the end of the bibliography, the following new references:

- [11] VG 95214-12, *Test of components – Part 12: Measuring methods for transfer impedance and screening attenuation, – transfer impedance of screened components (triaxial method, KS 12 B) and conductive gaskets (triaxial method, KS 22 B)*
- [12] VG 95214-13, *Test of components – Part 13: Measuring methods for transfer impedance and screening attenuation, screening attenuation of screened components (triaxial method, KS 13 B)*
- [13] VG 95319-2, *Electrical connectors and plug-and-socket devices – Part 2: Generic specification*
- [14] VG 95377-15, *Electromagnetic compatibility (EMC) – Measuring devices and measuring equipment – Part 15: Auxiliary measuring devices*

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